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				Application Number	Not Yet Assigned
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				First Named Inventor	Hajime KIMURA
				Group Art Unit	Not Yet Assigned
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	756-2317

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WJ		"Revised MOS Solid Image Pickup Element - Spreading Its Applications with Arms of Low Power Consumption", Nikkei Electronics, July 14, 1997, pp. 119-124	
WJ		"CMOS Image Sensors: Electronic Camera On a Chip", IEDM 95, pp.17-25	
WJ		"CMOS Image Sensors - Recent Advances and Device Scaling Considerations", IDEM 97, pp. 201-204	
WJ		"Survey of Development of CMOS Camera", JIEC Seminar, February 20, 1998, pp. 1-11	
WJ		"CCD for Digital Camera Steered from Exclusive Devotion to Pixel Number to Improvement in Sensitivity", Nikkei Electronics, December 14, 1998, pp. 47-52	
WJ		"Appearance of CCD Directed to Personal Computer Camera", Nikkei Electronics, April 24, 1995, pp. 159-168	
WJ		"Solid Image Pickup Element Cameras Having Been Reported These 18 Years", Nikkei Electronics, September 14, 1992, pp. 261-291	
WJ		"X-ray Detectors based on Amorphous Silicon Active MATRIX", Euro Display 99, pp. 203-207	
WJ		"Amorphous Silicon TFT X-ray Image Sensors", IEDM 98, pp. 21-24	
WJ		"Real-time Imaging Flat Panel X-ray Detector", AM-LCD'99, pp. 45-48	

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